General Description

PIN TO

mm x 3

The MAX8552 highly integrated monolithic MOSFET driver is capable of driving a pair of power MOSFETs in single or multiphase synchronous buck-converter applications that provide up to 30A output current per phase. The MAX8552 simplifies PC board layout in multiphase systems, particularly three phases and higher. High input voltages up to 24V allow the MAX8552 to be used in desktop, notebook, and server applications. Each MOSFET driver is capable of driving 3000pF capacitive loads with only 12ns propagation delay and 11ns (typ) rise and fall times, making the MAX8552 ideal for high-frequency applications.

User-programmable break-before-make circuitry prevents shoot-through currents, maximizing converter efficiency. An enable input allows total driver shutdown (<1 μ A typ) for power-sensitive portable applications. The PWM control input is compatible with TTL and CMOS logic levels. The MAX8522, along with the MAX8524 or the MAX8525 multiphase controllers, provides flexible 2-, 3-, 4-, 6-, or 8-phase CPU core-voltage supplies.

The MAX8552 is available in space-saving 10-pin TDFN and μ MAX packages and is specified for -40°C to +85°C operation.

Applications

Multiphase Buck Converters

Voltage Regulator Modules (VRMs)

Processor-Core Voltage Regulators

Desktops, Notebooks, and Servers

Switching Power Supplies

_Features

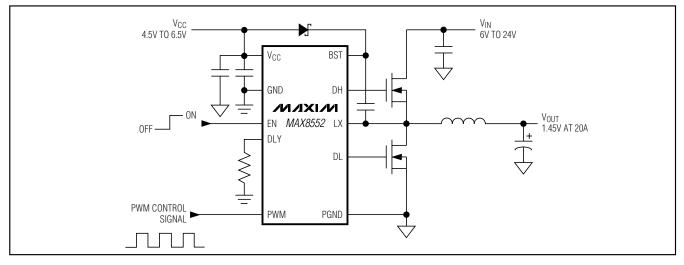
- Single-Phase Synchronous Drivers
- Up to 24V (max) Input Voltage
- ♦ 0.1µA (typ) Quiescent Current in Shutdown Over Temperature
- ♦ 0.5Ω/1.0Ω/0.7Ω/1.3Ω Rout Drivers
- 12ns (typ) Propagation Delay
- ♦ 11ns (typ) Rise/Fall Times with 3000pF Load
- Adaptive Dead Time and User-Programmable Delay Mode
- Up to 2MHz Operation with TDFN Package
- Up to 1.2MHz Operation with µMAX Package
- Enable Function
- TTL- and CMOS-Compatible Logic Inputs
- Available in a Space-Saving Thin DFN Package

Ordering Information

PART	TEMP RANGE	PIN-PACKAGE
MAX8552EUB	-40°C to +85°C	10 µMAX
MAX8552ETB	-40°C to +85°C	10 TDFN 3mm x 3mm

Pin Configurations appear at end of data sheet.

Typical Operating Circuit



M/IXI/M

_ Maxim Integrated Products 1

For pricing delivery, and ordering information please contact Maxim/Dallas Direct! at 1-888-629-4642, or visit Maxim's website at www.maxim-ic.com.

ABSOLUTE MAXIMUM RATINGS

V _{CC} to GND	
PWM, EN, DL, DLY to GND	0.3V to (V _{CC} + 0.3V)
BST to PGND	-0.3V to +35V
LX to PGND	1V to +28V
DH to PGND	0.3V to (V _{BST} + 0.3V)
DH, BST to LX	-0.3V to +7V
DH and DL Continuous Current.	±200mA

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

 $(V_{CC} = V_{BST} = V_{DLY} = V_{EN} = 5V, V_{GND} = V_{PGND} = V_{LX} = 0V; T_A = -40^{\circ}C$ to +85°C, unless otherwise noted. Typical values are at T_A = +25°C.) (Note 1)

PARAMETER	CO	MIN	ТҮР	MAX	UNITS	
UNDERVOLTAGE PROTECTIO	N					
V _{CC} Supply Voltage Range			4.5		6.5	V
	0.05) (by atoropia	V _{CC} rising	3.25		3.80	V
Undervoltage Lockout (UVLO)	0.25V hysteresis	V _{CC} falling	3.0		3.5	v
Ohu dalawar Quara lu Quara d		$\label{eq:PWM} \begin{array}{l} PWM = GND \text{ or } V_{CC}, \\ T_{A} = +25^{\circ}C \end{array}$		0.04	1	
Shutdown Supply Current	$V_{\rm EN} = 0V, V_{\rm CC} = 6.5V$	$\label{eq:pwm} \begin{array}{l} PWM = GND \text{ or } V_{CC}, \\ T_{A} = +85^{\circ}C \end{array}$		0.1		μA
Idle Supply Current (I _{CC})	No switching	$V_{CC} = 6.5V, PWM = GND, \\ R_{DLY} = 47k\Omega$		330	500	μA
	No switching	PWM = GND		25	50	μA
		$PWM = V_{CC}$		2	3	mA
Control Supply Current (I _{GND})	Switching	f _{PWM} = 250kHz, 50% duty cycle		1.8	3	mA
	No switching, I _{CC}	PWM = GND		0.1	10	μA
		$PWM = V_{CC}$		1.2	2	mA
Driver Supply Current (IPGND)		PWM = GND		0.1	10	μΑ
	No switching, IBST	$PWM = V_{CC}$	1.2		2	mA
	Switching, I _{BST} + I _{CC} 250kHz			2	4	
DRIVER SPECIFICATIONS (See	e the <i>Timing Diagram</i>)					
	PWM = GND,	$V_{BST} = 4.5V$		1.3	2.4	
DH Driver Resistance	sourcing current	$V_{BST} = 5V$		1.2		
	$PWM = V_{CC}$,	$V_{BST} = 4.5V$	0.7 1.1		1.1	Ω
	sinking current	$V_{BST} = 5V$		0.6	0.6	

ELECTRICAL CHARACTERISTICS (continued)

 $(V_{CC} = V_{BST} = V_{DLY} = V_{EN} = 5V, V_{GND} = V_{PGND} = V_{LX} = 0V; T_A = -40^{\circ}C$ to +85°C, unless otherwise noted. Typical values are at $T_A = +25^{\circ}C$.) (Note 1)

PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS	
	PWM = GND,	$V_{CC} = 4.5 V$		1.0	1.6		
DL Driver Resistance	sourcing current	$V_{CC} = 5V$		0.9			
	$PWM = V_{CC}$,	$V_{CC} = 4.5V$		0.5	0.8	Ω	
	sinking current	$V_{CC} = 5V$		0.45			
DH Rise Time (t _{rDH})	$PWM = V_{CC}$	V _{BST} = 5V, 3000pF load		14		ns	
DH Fall Time (t _{fDH})	PWM = GND	V _{BST} = 5V, 3000pF load		9		ns	
DL Rise Time (t _{rDL})	$PWM = V_{CC}$	V _{CC} = 5V, 3000pF load	Ī	11		ns	
DL Fall Time (t _{fDL})	PWM = GND	V _{CC} = 5V, 3000pF load		8		ns	
	PWM falling (t _{pDHf})	V _{BST} = 5V		12		ns	
DH Propagation Delay	PWM = V _{CC} , DL falling (t _{pDHr})	V _{BST} = 5V		14			
	PWM rising (t _{pDLf})			9		ns	
DL Propagation Delay	PWM = GND, LX falling (t _{pDLr})	$V_{BST} - V_{LX} = 5V$		16			
EN			•			•	
Lookana Queent	$V_{PWM} = 0V \text{ or } 6.5V, V_{EN} = 0V \text{ or } 6.5V, V_{CC} = 6.5V, T_A = +25^{\circ}C$			0.01	1		
Leakage Current	$V_{PWM} = 0V \text{ or } 6.5V, V_{EN} = 0V \text{ or } 6.5V, V_{CC} = 6.5V, T_A = +85^{\circ}C$			0.1	μΑ		
Input-Voltage High Threshold	$V_{\rm CC} = 6.5 V$				2.5	V	
Input-Voltage Low Threshold	$V_{CC} = 4.5V$		0.8			V	
PWM			•				
	$V_{PWM} = 0V \text{ or } 6.5V, V_{EN} = 0V \text{ or } 6.5V, V_{CC} = 6.5V, T_A = +25^{\circ}C$			0.01	1		
Leakage Current	$V_{PWM} = 0V \text{ or } 6.5V, V_{EN} = 0V \text{ or } 6.5V, V_{CC} = 6.5V, T_A = +85^{\circ}C$			0.1		- μΑ	
Input-Voltage High Threshold	$V_{CC} = 6.5V$				3.5	V	
Input-Voltage Low Threshold	$V_{CC} = 4.5V$		1.2			V	
Input Threshold Hysteresis				0.5		V	
DLY			·				
Delay Program Accuracy	$R_{DLY} = 47k\Omega$, DL fall to [OH rise	67.5	90.0	112.5	ns	
Delay Disable-Detection Threshold			4.0		4.7	V	

Note 1: Specifications are production tested at $T_A = +25^{\circ}C$. Maximum and minimum limits are guaranteed by design and characterization.

 $(V_{CC} = V_{DLY} = 5V, C_{HS_LOAD} = C_{LS_LOAD} = 3000pF, 50\%$ duty ratio.)

PACKAGE-POWER DISSIPATION PACKAGE-POWER DISSIPATION **DL RISE AND FALL TIMES** vs. CAPACITIVE LOAD ON DH AND DL vs. PWM FREQUENCY vs. CAPACITIVE LOAD 500 20 500 A: f_S = 300kHz A: C_{HS} = 3300pF; C_{LS} = 3300pF 450 450 18 **RISE TIME** B: C_{HS} = 3300pF; C_{LS} = 5600pF B: f_S = 600kHz ſ 400 400 16 C: f_S = 1MHz C: C_{HS} = 1500pF; C_{LS} = 3300pF RISE AND FALL TIME (ns) 350 350 14 300 300 12 (MM) (MM) В 250 250 10 2 £ 200 200 8 FALL TIME 150 150 6 100 100 4 C_{DH} = C_{DL} 2 50 50 $V_{CC} = 6.5V$ $V_{CC} = 6.5V$ 0 ٥ ٥ 400 600 800 1000 1200 1000 1500 2000 2500 3000 3500 4000 4500 5000 0 200 1000 2000 3000 4000 5000 PWM FREQUENCY (kHz) CAPACITANCE (pF) CAPACITANCE (pF) **DH RISE AND FALL TIMES** DH AND DL RISE AND FALL TIMES **CONTROL-CIRCUITRY CURRENT** vs. CAPACITIVE LOAD vs. TEMPERATURE vs. PWM FREQUENCY 18 25 1.2 DH RISE **RISE TIME** 16 1.0 20 14 DL RISE $V_{CC} = 6.5V$ RISE AND FALL TIME (ns) RISE AND FALL TIME (ns) 12 0.8 15 DH FAL IGND (mA) > 10 0.6 $V_{CC} = 5V$ 8 10 DI FALL 6 0.4 FALL TIME 2 5 $V_{EN} = 0V$ 0.2 4 0 0 0 40 60 80 1000 1500 2000 2500 3000 3500 4000 4500 5000 -40 -20 0 20 100 120 0 200 400 600 800 1000 1200 CAPACITANCE (pF) TEMPERATURE (°C) PWM FREQUENCY (kHz) **PROGRAMMABLE DELAY (tply) PROPAGATION DELAY TYPICAL APPLICATION CIRCUIT** vs. TEMPERATURE **VS. RDLY** SWITCHING WAVEFORMS 30 200 180 DL FALL TO DH RISE 25 160 Vpwm PROGRAMMABLE DELAY (ns) 5V/div PROPAGATION DELAY (ns) 140 mm 20 120 V_{LX} 100 10V/div 15 PWM FALL TO DH FALL 80 10 60 VDL 5V/div PWM RISE TO DL FALL 40 5 20 0 0 VDH 20V/div -20 0 40 60 80 100 120 25 45 65 85 -40 20 5 105 125 100ns/div TEMPERATURE (°C) $R_{DLY}(k\Omega)$

Typical Operating Characteristics

M/X/M

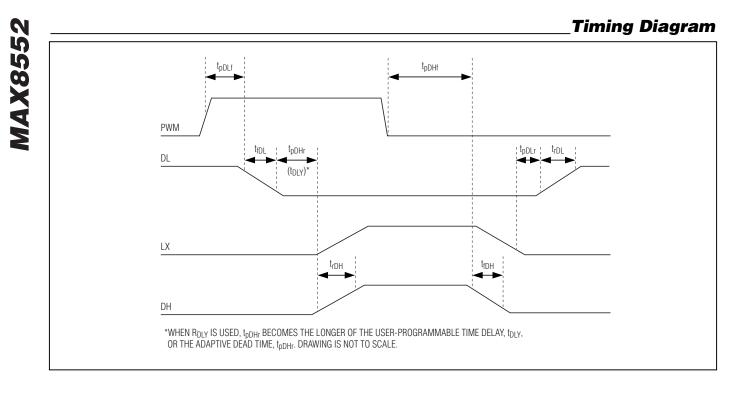
MAX8552

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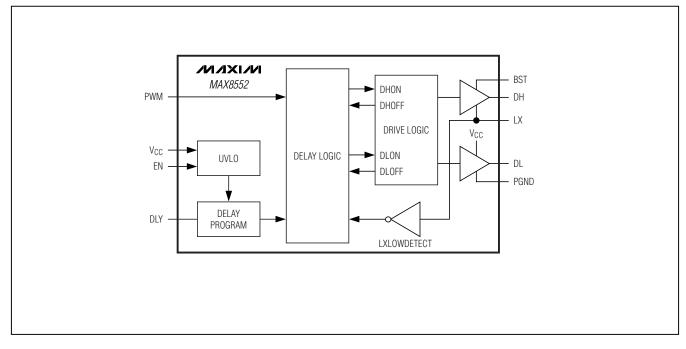
Pin Description

PIN	NAME	FUNCTION
1	V _{CC}	Input Supply Voltage. Connect to a supply voltage in the 4.5V to 6.5V range. Bypass to PGND with a 2.2μ F or larger capacitor, and bypass to GND with a 0.47μ F or larger capacitor.
2	DL	External Synchronous-Rectifier N-MOSFET Gate-Driver Output. Swings between V_{CC} and PGND. Anticrowbar feature prevents DL from turning on until DH is off and (LX - PGND) < 2V. DL is pulled to GND in shutdown.
3	PGND	Power Ground
4	GND	Analog Ground
5	DLY	Dead-Time Delay Programming Input. Connect a resistor from DLY to GND to set the dead-time delay between when DL falls and when DH rises. Connect DLY to V_{CC} to disable the delay function. See the <i>Typical Operating Characteristics</i> for R_{DLY} selection.
6	PWM	PWM Input. DH is high when PWM is high; DL is high when PWM is low. Input frequency can be as high as 1.2MHz for the 10-pin µMAX package and as high as 2MHz for the 10-pin TDFN package.
7	EN	Enable Input. Drive high to enable output drivers. Drive low to disable output drivers and place the IC in low-power shutdown mode.
8	LX	Switching Node and Inductor Connection. Low power supply for the DH high-side gate driver. Connect to the source of the high-side N-MOSFET and the drain of the low-side N-MOSFET, as well as the switched side of the inductor.
9	DH	External High-Side N-MOSFET Gate-Driver Output. Swings between LX and BST. Anticrowbar feature delays DH from turning on until DL is off. An additional user-programmable delay can be added. DH is pulled to LX in shutdown.
10	BST	Boost Flying-Capacitor Connection. Gate-drive power supply for DH high-side gate driver. Connect a 0.47µF or larger capacitor between BST and LX.
	Exposed Paddle*	Exposed Paddle. Connect to GND.

*10-pin TDFN only.



Functional Diagram



Detailed Description

The MAX8552 single-phase gate driver, along with the MAX8524/MAX8525 multiphase controllers, provide flexible one- to eight-phase CPU core-voltage supplies. The $1.0\Omega/1.3\Omega$ driver resistance allows up to 30A output current per phase. Each MOSFET driver in the MAX8552 is capable of driving 3000pF capacitive loads with only 12ns propagation delay and 11ns (typ) rise and fall times, allowing operation up to 1.2MHz per phase. Adaptive dead time controls MOSFET turn-on, and user-programmable dead time provides additional flexibility for high-side MOSFET turn-on. This maximizes converter efficiency, while allowing operation with a varietv of MOSFETs and PWM-controller ICs. An undervoltage-lockout circuit allows proper power-on sequencing. The PWM signal input is both TTL and CMOS compatible. An enable input allows total driver shutdown (<0.1µA typ) for power-sensitive portable applications.

MOSFET Gate Drivers (DH, DL)

The high-side driver (DH) has a 1.3Ω (typ) sourcing resistance and 0.7Ω sinking resistance, resulting in 4A peak sourcing current and 7A peak sinking current with a 5V supply voltage. The low-side driver (DL) has a typical 1.0Ω sourcing resistance and 0.5Ω sinking resistance, yielding 5A peak sourcing current and 10A peak sinking current. This reduces switching losses, making the MAX8552 ideal for both high-frequency and high-output-current applications.

Shoot-Through Protection and Programmable Delay (t_{DLY})

The MAX8552 incorporates adaptive shoot-through protection for the switching transition after the high-side MOSFET turns off and before the low-side MOSFET turns on and vice versa. The low-side driver turns on only when the LX voltage falls below 2.4V. Furthermore, the delay time between the low-side MOSFET turn-off and high-side MOSFET turn-on can be adjusted by selecting the value of R1 (see the *RDLY Selection* section).

Undervoltage Lockout

When V_{CC} is below the UVLO threshold (3.5V typ), DH and DL are held low. Once V_{CC} is above the UVLO threshold and while PWM is low, DL is driven high and DH is driven low. This prevents the output of the converter from rising before a valid PWM signal is applied.

EN

When EN is low, the MAX8552 is in shutdown mode and the total input current is reduced to less than 1μ A for power-sensitive applications. In shutdown mode, both DH and DL are held low. When EN goes high, the MAX8552 becomes active.

Applications Information

Decoupling of Vcc

 V_{CC} provides the supply voltage for the internal logic circuits. Bypass V_{CC} with a 2.2µF or larger capacitor to PGND and a 0.47µF or larger capacitor to GND to limit noise to the internal circuitry. Connect these bypass capacitors as close to the IC as possible.

Boost Flying-Capacitor Selection

The MAX8552 uses a bootstrap circuit to generate the necessary drive voltage (V_{DH}) to fully enhance the high-side N-MOSFET. The selected high-side MOSFET determines appropriate boost capacitance values (C6 in the Typical Application Circuit, Figure 1), according to the following equation:

$C_{BST} = Q_{GATE} / \Delta V_{BST}$

where Q_{GATE} is the total gate charge of the high-side MOSFET and ΔV_{BST} is the voltage variation allowed on the high-side MOSFET driver. Choose $\Delta V_{BST} = 0.1V$ to 0.2V when determining C_{BST}. The boost flying-capacitor should be a low-equivalent series resistance (ESR) ceramic capacitor.

RDLY Selection

Connect DLY to V_{CC} to disable the programmable delay function and default to the adaptive delay time. To program a longer specific delay time between the low-side MOSFET driver turn-off and the high-side MOSFET turnon, connect a delay resistor, R_{DLY}, between DLY and GND (R1 in the Typical Application Circuit, Figure 1). See the *Typical Operating Characteristics* to select R_{DLY}.

Avoiding dV/dt Turning on the Low-Side MOSFET

At high input voltages, fast turn-on of the high-side MOSFET can momentarily turn on the low-side MOSFET due to the high dV/dt appearing at the drain of the low-side MOSFET. The high dV/dt causes a current flow through the Miller capacitance (CRSS) and the input capacitance (CISS) of the low-side MOSFET. Improper selection of the low-side MOSFET that results in a high ratio of CRSS/CISS makes the problem more severe. To avoid this problem, minimize the ratio of CRSS/CISS when selecting the low-side MOSFET. Adding a 1 Ω resistor between BST and CBST can slow the high-side MOSFET turn-on. Similarly, adding a small capacitor from the gate to the source of the high-side MOSFET has the same effect. However, both methods work at the expense of increased switching losses.





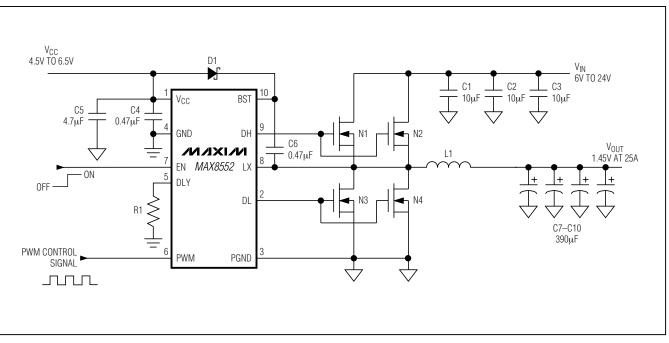


Figure 1. Typical Application Circuit

DESIGNATION	DESCRIPTION	PART	
C1, C2, C3	10µF, 25V ceramic capacitor	Taiyo Yuden TMK432BJ106MM	
C4	4.7µF, 10V ceramic capacitor	Taiyo Yuden LMK316 BJ475ML	
C5, C6	0.47µF, 10V ceramic capacitor	Taiyo Yuden LMK107BJ474KA	
C7–C10	390µF/2V SP capacitor	Panasonic EEFUE0D391XR	
D1	30V, 200mA, V _F = 0.5V Schottky diode	Fairchild BAT54S	
L1	0.66 μ H/29A, 0.9m Ω typical R _{DC} resistance	Panasonic PCC-NX3	
N1, N2	30V, 14A N-MOSFET	International Rectifier IRF7821	
N3, N4	30V, 18A N-MOSFET	International Rectifier IRF7832	
R1	$6k\Omega - 125k\Omega = 1\%$, 1/8W resistor	Panasonic	

Tabla 1	Typical Com	nonent Values	(500kH7 0	noration	25A/Dhase O	utput Current)
Table I.	Typical Com	ponent values		peration,	23A/Filase U	ulpul Current)

Layout Guidelines

The MAX8552 MOSFET driver sources and sinks large currents to drive MOSFETs at high switching speeds. The high di/dt can cause unacceptable ringing if the trace lengths and impedances are not well controlled. The following PC board layout guidelines are recommended when designing with the MAX8552:

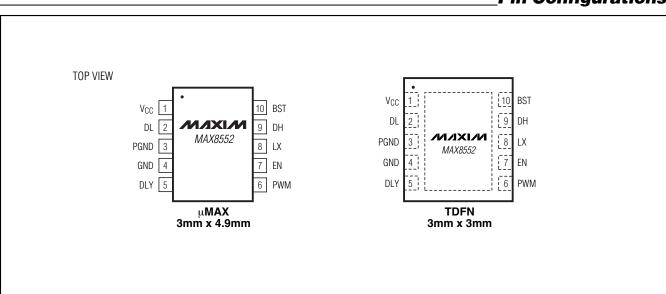
- 1) Place all decoupling capacitors as close to their respective IC pins as possible.
- 2) Minimize the length of the high-current loop from the input capacitor, the upper switching MOSFET, and the low-side MOSFET back to the input-capacitor negative terminal.
- Provide enough copper area at and around the switching MOSFETs and inductors to aid in thermal dissipation.

- 4) Connect PGND of the MAX8552 as close as possible to the source of the low-side MOSFETs.
- 5) Keep LX away from sensitive analog components and nodes. Place the IC and the analog components on the opposite side of the board from the power-switching node if possible.

A sample layout is available in the MAX8552 evaluation kit.

Chip Information

TRANSISTOR COUNT: 638 PROCESS: BICMOS



Pin Configurations

Package Information

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information go to **www.maxim-ic.com/packages**.)

